

Ultra Series[™] Crystal Oscillator (VCXO) Si567 Data Sheet

Ultra Low Jitter Quad Any-Frequency VCXO (100 fs), 0.2 to 3000 MHz

The Si567 Ultra Series[™] voltage-controlled crystal oscillator utilizes Silicon Laboratories' advanced 4th generation DSPLL[®] technology to provide an ultra-low jitter, low phase noise clock at four selectable frequencies. The device is factoryprogrammed to provide any four selectable frequencies from 0.2 to 3000 MHz with <1 ppb resolution and maintains exceptionally low jitter for both integer and fractional frequencies across its operating range. On-chip power supply filtering provides industry-leading power supply noise rejection, simplifying the task of generating low jitter clocks in noisy systems that use switched-mode power supplies. Offered in industry-standard footprints, the Si567 has a dramatically simplified supply chain that enables Silicon Labs to ship custom frequency samples 1-2 weeks after receipt of order. Unlike a traditional XO, where a different crystal is required for each output frequency, the Si567 uses one simple crystal and a DSPLL IC-based approach to provide the desired output frequencies. The Si567 is factory-configurable for a wide variety of user specifications, including frequency, output format, and OE pin location/polarity. Specific configurations are factory-programmed at time of shipment, eliminating the long lead times associated with custom oscillators.

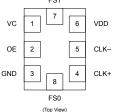




5 x 7 mm and 3.2 x 5 mm

2.5 x 3.2 mm



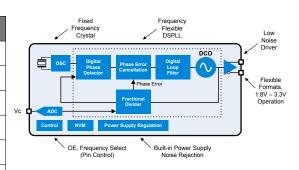


KEY FEATURES

- Available with any four selectable frequencies from 200 kHz to 3000 MHz
- Ultra low jitter: 100 fs RMS typical (12 kHz – 20 MHz)
- Excellent PSNR and supply noise immunity: -80 dBc Typ
- 3.3 V, 2.5 V and 1.8 V V_{DD} supply operation from the same part number
- LVPECL, LVDS, CML, HCSL, CMOS, and Dual CMOS output options
- 2.5x3.2, 3.2x5, 5x7 mm package options
- Samples available with 1-2 week lead times

APPLICATIONS

- · 100G/200G/400G OTN, coherent optics
- 10G/25G/40G/100G Ethernet
- · 56G/112G PAM4 clocking
- 3G-SDI/12G-SDI/24G-SDI broadcast video
- Servers, switches, storage, NICs, search acceleration
- Test and measurement
- FPGA/ASIC clocking



Pin #	Descriptions
1	VC = Voltage Control Pin
2	OE = Output enable
3	GND = Ground
4	CLK+ = Clock output
5	CLK- = Complementary clock output. Not used for CMOS.
6	VDD = Power supply
7	FS1 = Frequency Select 1
8	FS0 = Frequency Select 0

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1. Ordering Guide

The Si567 VCXO supports a variety of options including frequency, output format, and OE pin location/polarity, as shown in the chart below. Specific device configurations are programmed into the part at time of shipment, and samples are available in 1-2 weeks. Silicon Laboratories provides an online part number configuration utility to simplify this process. Refer to www.silabs.com/oscillators to access this tool and for further ordering instructions.

VCXO Series	Description			Code	OE Pin	OE Polar	rity		Pac	kage		Temperatu	ire Grade
567	Quad Frequency	/CXO		Α	Pin 2	Active Hi	gh	Α	5x7	mm	G	-40 to	85 °C
				В	Pin 2	Active Lo	w	В	3.2x	5 mm			
								С	2.5x3	.2 mm			
567 A A A A B G R Device Revision													
		Order	1									Code	Reel
Signal Format	VDD Range	Option										R	Tape and Reel
LVPECL	2.5, 3.3 V	Α	1 ,		Temperat	ure Stabili	ty = ± 20	ppm				<blank></blank>	Coil Tape
LVDS	1.8, 2.5, 3.3 V	В	1	V	c Tuning	Min APR	≀ [± ppm]	at VD					
CMOS	1.8, 2.5, 3.3 V	С		K	Slope / [ppm/V]	3.3V	2.5V	1.8	v	Freque		De	escription
CML	1.8, 2.5, 3.3 V	D		A	60	20						Four unique f	requencies can be
HCSL	1.8, 2.5, 3.3 V	E		В	75	40	20					specified with	in the supported range
Dual CMOS (In-Phase)	1.8, 2.5, 3.3 V	F		С	105	70	40	20)	xxxx	of the selected signal forma frequencies can be arrange		an be arranged in any
Dual CMOS	1.8, 2.5, 3.3 V	G	1 L	D	150	115	75	45	5			order from FS	[1:0]=00 to six digit numeric code
(Complementary	/)	G		E	180	145	100	65	5				ed for the specific
		Х		F	225	190	135	85		1		combination of	

Notes:

1. Contact Silicon Labs for non-standard configurations.

2. Create custom part numbers at www.silabs.com/oscillators.

3. Min Absolute Pull Range (APR) includes temp stability, initial accuracy, load pulling, VDD variation, and 20 year aging at 70 °C.

- a. For best jitter and phase noise performance, always choose the smallest Kv that meets the application's minimum APR requirements. Unlike SAW-based solutions which require higher Kv values to account for their higher temperature dependence, the Si56x series provides lower Kv options to minimize noise coupling and jitter in real-world PLL designs.
- b. APR is the ability of a VCXO to track a signal over the product lifetime. A VCXO with an APR of ±20 ppm is able to lock to a clock with a ±20 ppm stability over 20 years over all operating conditions.
- c. APR (±) = (0.5 x VDD x tuning slope) (initial accuracy + temp stability + load pulling + VDD variation + aging).
- d. Minimum APR values noted above include absolute worst case values for all parameters.
- e. See application note, "AN266: VCXO Tuning Slope (Kv), Stability, and Absolute Pull Range (APR)" for more information.

1.1 Technical Support

Frequently Asked Questions (FAQ)	www.silabs.com/Si567-FAQ
Oscillator Phase Noise Lookup Utility	www.silabs.com/oscillator-phase-noise-lookup
Quality and Reliability	www.silabs.com/quality
Development Kits	www.silabs.com/oscillator-tools

2. Electrical Specifications

Table 2.1. Electrical Specifications

 V_{DD} = 1.8 V, 2.5 or 3.3 V \pm 5%, T_A = –40 to 85 °C

Parameter	Symbol	Test Condition/Comment	Min	Тур	Max	Unit
Temperature Range	T _A		-40	_	85	°C
Frequency Range	F _{CLK}	LVPECL, LVDS, CML	0.2		3000	MHz
		HCSL	0.2		400	MHz
		CMOS, Dual CMOS	0.2		250	MHz
Supply Voltage	V _{DD}	3.3 V	3.135	3.3	3.465	V
		2.5 V	2.375	2.5	2.625	V
		1.8 V	1.71	1.8	85 3000 400 250 3.465 2.625 1.89 170 140 145 155 20 350 1.5 550 55 0.3 × V _{DD} 3 20 1.9	V
Supply Current	I _{DD}	LVPECL (output enabled)	—	120	170	mA
		LVDS/CML (output enabled)	—	100	140	mA
		HCSL (output enabled)	—	95	140	mA
		CMOS (output enabled)	—	95	145	mA
		Dual CMOS (output enabled)	—	105	155	mA
		Tristate Hi-Z (output disabled)	_	83	_	mA
Temperature Stability ¹		-40 to 85 °C	-20	—	20	ppm
Rise/Fall Time (20% to 80% V _{PP}) Duty Cycle	T _R /T _F	LVPECL/LVDS/CML	—		350	ps
		CMOS / Dual CMOS (C _L = 5 pF)	_	0.5	1.5	ns
		HCSL, F _{CLK} >50 MHz	_		550	ps
Duty Cycle	D _C	All formats	45		55	%
Output Enable (OE)	V _{IH}		0.7 × V _{DD}		_	V
Frequency Select (FS0, FS1) ²	VIL		_		0.3 × V _{DD}	V
	T _D	Output Disable Time, F _{CLK} > 10 MHz	_		3	μs
	TE	Output Enable Time, F _{CLK} > 10 MHz	_		20	μs
	T _{FS}	Settling Time after FS Change	_		10	ms
Powerup Time	tosc	Time from 0.9 × V _{DD} until output fre- quency (F _{CLK}) within spec	_		10	ms
Powerup VDD Ramp Rate	V _{RAMP}	Fastest V _{DD} ramp rate allowed on startup	-		9	V/ms
LVPECL Output Option ³	V _{OC}	Mid-level	V _{DD} – 1.42		V _{DD} – 1.25	V
	V _O	Swing (diff, F _{CLK} ≤ 1.5 GHz)	1.1		1.9	V _{PP}
		Swing (diff, F _{CLK} > 1.5 GHz) ⁶	0.55		1.7	V _{PP}

Parameter	Symbol	Test Condition/Comment	Min	Тур	Max	Unit
LVDS Output Option ⁴	V _{OC}	Mid-level (2.5 V, 3.3 V VDD)	1.125	1.20	1.275	V
		Mid-level (1.8 V VDD)	0.8	0.9	1.0	V
	V _O	Swing (diff, F _{CLK} ≤ 1.4 GHz)	0.6	0.7	0.9	V _{PP}
		Swing (diff, F _{CLK} > 1.4 GHz) ⁶	0.25	0.5	0.8	V _{PP}
HCSL Output Option ⁵	V _{OH}	Output voltage high	660	800	850	mV
	V _{OL}	Output voltage low	-150	0	150	mV
	V _C	Crossing voltage	250	410	550	mV
CML Output Option (AC-Coupled)	V _O	Swing (diff, F _{CLK} ≤ 1.5 GHz) ⁶	0.6	0.8	1.0	V _{PP}
		Swing (diff, F _{CLK} > 1.5 GHz) ⁶	0.3	0.55	0.9	V _{PP}
CMOS Output Option	V _{OH}	I _{OH} = 8/6/4 mA for 3.3/2.5/1.8 V VDD	$0.85 \times V_{DD}$	_	—	V
	V _{OL}	I _{OL} = 8/6/4 mA for 3.3/2.5/1.8 V VDD	—		0.15 × V _{DD}	V

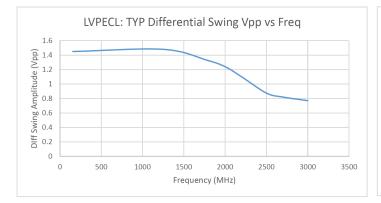
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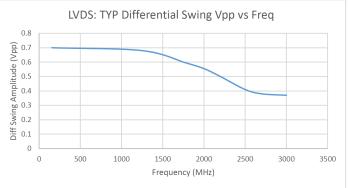
1. Min APR includes temperature stability, initial accuracy, load pulling, VDD variation, and aging for 20 yrs at 70 °C.

2. OE includes a 50 k Ω pull-up to VDD for OE active high, or includes a 50 k Ω pull-down to GND for OE active low. FS0 and FS1 pins each include a 50 k Ω pull-up to VDD.

3. R_{term} = 50 Ω to V_{DD} – 2.0 V (see Figure 4.1).

- 4. R_{term} = 100 Ω (differential) (see Figure 4.2).
- 5. R_{term} = 50 Ω to GND (see Figure 4.2).
- 6. Refer to the figure below for Typical Clock Output Swing Amplitudes vs Frequency.





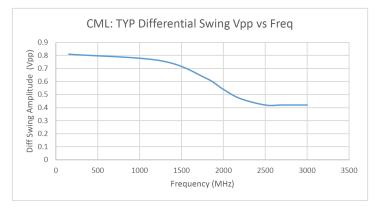


Figure 2.1. Typical Clock Output Swing Amplitudes vs. Frequency

Table 2.2. V_C Control Voltage Input

V_{DD} = 1.8, 2.5 or 3.3 V \pm 5%, T_A = –40 to 85 °C

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Control Voltage Range	V _C		0.1 x VDD	VDD/2	0.9 x VDD	V
Control Voltage Tuning Slope (Vc = 10% VDD to 90% VDD)	Kv	Positive slope, ordering option	60, 75, 105, 150, 180, 225			ppm/V
Kv Variation	Kv_var		_	_	±10	%
Control Voltage Linearity	LVC	Best Straight Line fit	-1.5	±0.5	+1.5	%
Modulation Bandwidth	BW		_	10	_	kHz
Vc Input Impedance	ZVC		500	_	_	kΩ

Table 2.3. Clock Output Phase Jitter and PSNR

V_{DD} = 1.8 V, 2.5 or 3.3 V ± 5%, T_A = –40 to 85 °C

Parameter	Symbol	Test Condition/Comment	Min	Тур	Max	Unit
Phase Jitter (RMS, 12 kHz - 20 MHz) ¹	φJ	Kv = 60 ppm/V	_	100	150	fs
All Differential Formats, $F_{CLK} \ge 200 \text{ MHz}$		Kv = 75 ppm/V	—	103	_	fs
		Kv = 105 ppm/V	_	110		fs
		Kv = 150 ppm/V	_	123	_	fs
		Kv = 180 ppm/V	—	132	_	fs
		Kv = 225 ppm/V	_	150	_	fs
Phase Jitter (RMS, 12 kHz - 20 MHz) ¹	φJ	Kv = 60 ppm/V	_	115	180	fs
All Diff Formats, 100 MHz $\leq F_{CLK} < 200$ MHz		Kv = 75 ppm/V	—	118		fs
		Kv = 105 ppm/V	_	125	_	fs
		Kv = 150 ppm/V	_	138	_	fs
		Kv = 180 ppm/V	_	147	_	fs
		Kv = 225 ppm/V	_	165	_	fs
Phase Jitter (RMS, 12 kHz - 20 MHz) ¹	φJ	Kv = 60 ppm/V	_	110	130	fs
LVDS, F _{CLK} = 156.25 MHz		Kv = 75 ppm/V	_	113	_	fs
		Kv = 105 ppm/V	_	120	_	fs
		Kv = 150 ppm/V	_	133	_	fs
		Kv = 180 ppm/V	_	142	_	fs
		Kv = 225 ppm/V	_	160	_	fs
Phase Jitter (RMS, 12 kHz - 20 MHz) ¹ CMOS / Dual CMOS Formats	φJ	10 MHz ≤ F _{CLK} < 250 MHz	_	200	_	fs

Parameter	Symbol	Test Condition/Comment	Min	Тур	Max	Unit
Spurs Induced by External Power Supply Noise, 50 mVpp Ripple. LVDS 156.25 MHz Output	PSNR	100 kHz sine wave		-83		dBc
	-	200 kHz sine wave		-83		
		500 kHz sine wave		-82		
		1 MHz sine wave		-85		
Note:						

1. Guaranteed by characterization. Jitter inclusive of any spurs.

Table 2.4.	. 3.2 x 5 mm Clock Output Phase N	Noise (Typical)
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Offset Frequency (f)	156.25 MHz LVDS	200 MHz LVDS	644.53125 MHz LVDS	Unit
100 Hz	-73	-71	-60	
1 kHz	-102	-102	-93	
10 kHz	-130	-128	-118	
100 kHz	-141	-139	–129	dBc/Hz
1 MHz	-150	-148	–138	
10 MHz	–159	-160	–153	
20 MHz	-160	-162	-154	
Offset Frequency (f)	156.25 MHz LVPECL	200 MHz LVPECL	644.53125 MHz LVPECL	Unit
100 Hz	-72	-71	-60	
1 kHz	-103	-101	-92	
10 kHz	-130	-127	–117	
100 kHz	-142	-139	–129	dBc/Hz
1 MHz	-150	-148	–138	
10 MHz	-160	-162	-154	
20 MHz	-161	-162	-156	

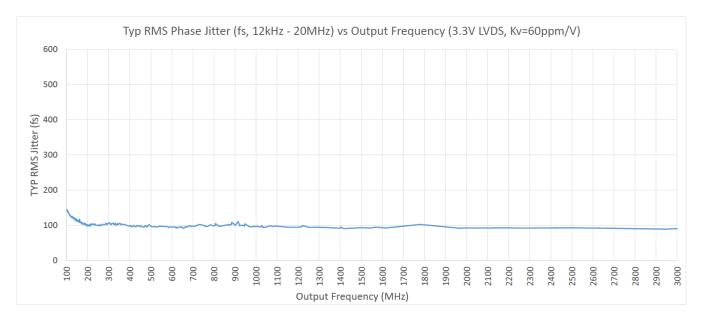


Figure 2.2. Phase Jitter vs. Output Frequency

Phase jitter measured with Agilent E5052 using a differential-to-single ended converter (balun or buffer). Measurements collected for >700 commonly used frequencies. Phase noise plots for specific frequencies are available using our free, online Oscillator Phase Noise Lookup Tool at www.silabs.com/oscillators.

Parameter	Test Condition
Mechanical Shock	MIL-STD-883, Method 2002
Mechanical Vibration	MIL-STD-883, Method 2007
Solderability	MIL-STD-883, Method 2003
Gross and Fine Leak	MIL-STD-883, Method 1014
Resistance to Solder Heat	MIL-STD-883, Method 2036
Moisture Sensitivity Level (MSL): 3.2 x 5, 5 x 7 packages	1
Moisture Sensitivity Level (MSL): 2.5 x 3.2 package	2
Contact Pads: 3.2x5, 5x7 packages	Au/Ni (0.3 - 1.0 μm / 1.27 - 8.89 μm)
Contact Pads: 2.5x3.2 packages	Au/Pd/Ni (0.03 - 0.12 μm / 0.1 - 0.2 μm / 3.0 - 8.0 μm)

Table 2.5. Environmental Compliance and Package Information

Note:

1. For additional product information not listed in the data sheet (e.g. RoHS Certifications, MDDS data, qualification data, REACH Declarations, ECCN codes, etc.), refer to our "Corporate Request For Information" portal found here: www.silabs.com/support/ quality/Pages/RoHSInformation.aspx.

Table 2.6. Thermal Conditions¹

Max Junction Temperature = 125° C

Package	Parameter	Symbol	Test Condition	Value	Unit
	Thermal Resistance Junction to Ambient	Θ_{JA}	Still Air, 85 °C	72	°C/W
2.5 x 3.2 mm 8-pin DFN ²	Thermal Parameter Junction to Board	Ψ _{JB}	Still Air, 85 °C	38	°C/W
	Thermal Parameter Junction to Top Center	Ψ_{JT}	Still Air, 85 °C	15	°C/W
	Thermal Resistance Junction to Ambient	Θ _{JA}	Still Air, 85 °C	55	°C/W
3.2 × 5 mm 8-pin CLCC	Thermal Parameter Junction to Board	Ψ_{JB}	Still Air, 85 °C	20	°C/W
	Thermal Parameter Junction to Top Center	Ψ_{JT}	Still Air, 85 °C	20	°C/W
	Thermal Resistance Junction to Ambient	Θ _{JA}	Still Air, 85 °C	53	°C/W
5 × 7 mm 8-pin CLCC	Thermal Parameter Junction to Board	Ψ_{JB}	Still Air, 85 °C	26	°C/W
	Thermal Parameter Junction to Top Center	Ψ_{JT}	Still Air, 85 °C	26	°C/W

Note:

1. Based on PCB Dimensions: 4.5" x 7", PCB Thickness: 1.6 mm, Number of Cu Layers: 4.

2. For best 2.5x3.2mm thermal performance, use 2 GND vias as shown in the Si5xxUC-EVB eval board layout

Table 2.7. Absolute Maximum Ratings¹

Parameter	Symbol	Rating	Unit
Maximum Operating Temp.	T _{AMAX}	95	°C
Storage Temperature	T _S	–55 to 125	°C
Supply Voltage	V _{DD}	-0.5 to 3.8	°C
Input Voltage	V _{IN}	–0.5 to V _{DD} + 0.3	V
ESD HBM (JESD22-A114)	HBM	2.0	kV
Solder Temperature ²	Треак	260	°C
Solder Time at T _{PEAK} ²	T _P	20–40	sec

Notes:

1. Stresses beyond those listed in this table may cause permanent damage to the device. Functional operation specification compliance is not implied at these conditions. Exposure to maximum rating conditions for extended periods may affect device reliability.

2. The device is compliant with JEDEC J-STD-020.

3. Dual CMOS Buffer

Dual CMOS output format ordering options support either complementary or in-phase signals for two identical frequency outputs. This feature enables replacement of multiple VCXOs with a single Si567 device.

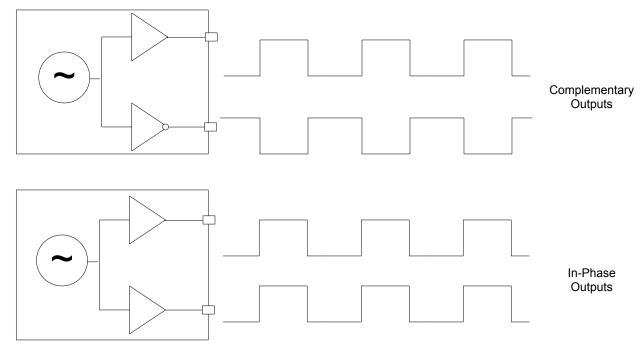


Figure 3.1. Integrated 1:2 CMOS Buffer Supports Complementary or In-Phase Outputs

4. Recommended Output Terminations

The output drivers support both AC-coupled and DC-coupled terminations as shown in figures below.

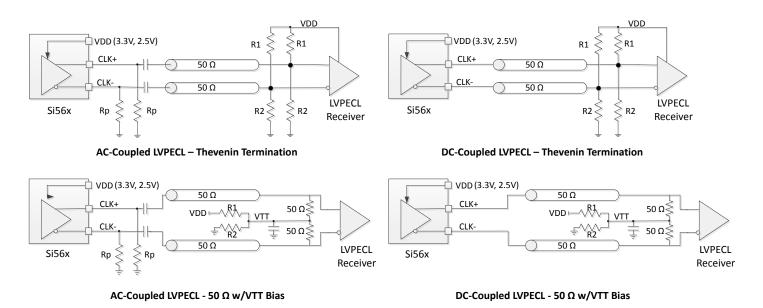
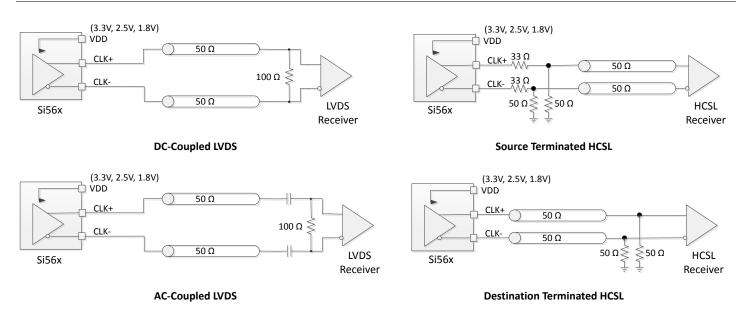


Figure 4.1. LVPECL Output Terminations

AC-Coupled LVPECL Termination Resistor Values				DC-Coupled LVPECL mination Resistor Va		
VDD	R1	R2	Rp	VDD	R1	R2
3.3 V	127 Ω	82.5 Ω	130 Ω	3.3 V	127 Ω	82.5 Ω
2.5 V	250 Ω	62.5 Ω	90 Ω	2.5 V	250 Ω	62.5 Ω





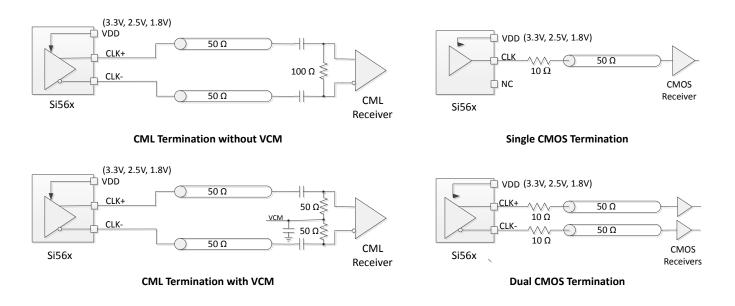


Figure 4.3. CML and CMOS Output Terminations

5. Package Outline

5.1 Package Outline (5x7 mm)

The figure below illustrates the package details for the 5x7 mm Si567. The table below lists the values for the dimensions shown in the illustration.

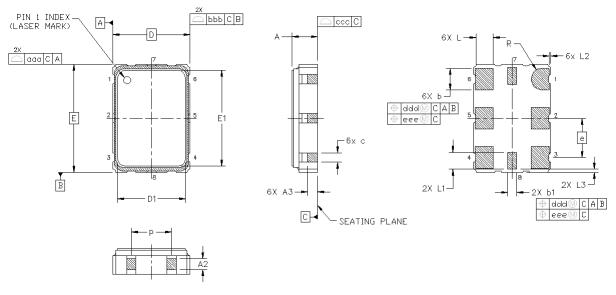


Figure 5.1. Si567 (5x7 mm) Outline Diagram

Dimension	Min	Nom	Мах	Dimension	Min	Nom	Max
А	1.07	1.18	1.33	L	1.07	1.17	1.27
A2	0.40	0.50	0.60	L1	1.00	1.10	1.20
A3	0.45	0.55	0.65	L2	0.05	0.10	0.15
b	1.30	1.40	1.50	L3	0.15	0.20	0.25
b1	0.50	0.60	0.70	р	1.70		1.90
С	0.50	0.60	0.70	R		0.70 REF	
D		5.00 BSC		ааа	0.15		
D1	4.30	4.40	4.50	bbb		0.15	
е	2.54 BSC			ссс		0.08	
E	7.00 BSC		ddd	0.10			
E1	6.10 6.20 6.30		eee		0.05		

Table 5.1. Package Diagram Dimensions (mm)

Notes:

1. All dimensions shown are in millimeters (mm) unless otherwise noted.

2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

5.2 Package Outline (3.2x5 mm)

The figure below illustrates the package details for the 3.2x5 mm Si567. The table below lists the values for the dimensions shown in the illustration.

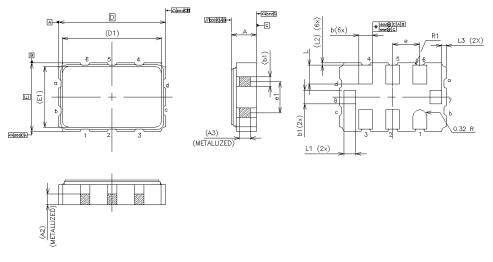


Figure 5.2. Si567 (3.2x5 mm) Outline Diagram

Table 5.2.	Package	Diagram	Dimensions	(mm)
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Dimension	MIN	NOM	MAX	Dimension	MIN	NOM	MAX
A	1.02	1.17	1.33	E1		2.85 BSC	
A2	0.50	0.55	0.60	L	0.8	0.9	1.0
A3	0.45	0.50	0.55	L1	0.45	0.55	0.65
b	0.54	0.64	0.74	L2	0.05	0.10	0.15
b1	0.54	0.64	0.75	L3	0.15	0.20	0.25
D		5.00 BSC		aaa	0.15		
D1		4.65 BSC		bbb	0.15		
е		1.27 BSC		ccc	0.08		
e1	1.625 TYP			ddd	0.10		
E	3.20 BSC			eee		0.05	
Notes:							

1. All dimensions shown are in millimeters (mm) unless otherwise noted.

2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

5.3 Package Outline (2.5x3.2 mm)

The figure below illustrates the package details for the 2.5x3.2 mm Si567. The table below lists the values for the dimensions shown in the illustration.

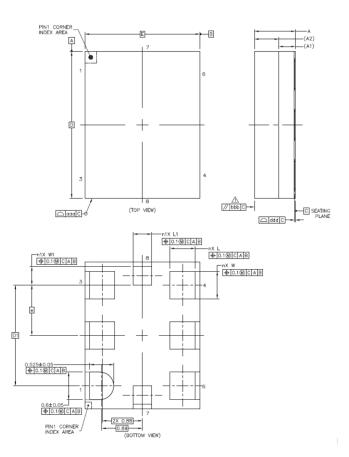


Figure 5.3. Si567 (2.5x3.2 mm) Outline Diagram

Dimension	MIN	NOM	MAX	Dimension	MIN	NOM	MAX
A	—	—	1	L1	0.35	0.4	0.45
A1	0.36 REF			е	1.1 BSC		
A2	0.53 REF			n	5		
D	3.2 BSC			n1	2		
E	2.5 BSC			D1		2.2 BSC	
W	0.55	0.6	0.65	aaa		0.10	
L	0.5	0.5 0.55 0.6		bbb		0.10	
W1	0.35	0.4	0.45	ddd		0.08	

Table 5.3. Package Diagram Dimensions (mm)

Notes:

1. The dimensions in parentheses are reference.

2. All dimensions shown are in millimeters (mm) unless otherwise noted.

3. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

4. Recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

6. PCB Land Pattern

6.1 PCB Land Pattern (5x7 mm)

The figure below illustrates the 5x7 mm PCB land pattern for the Si567. The table below lists the values for the dimensions shown in the illustration.

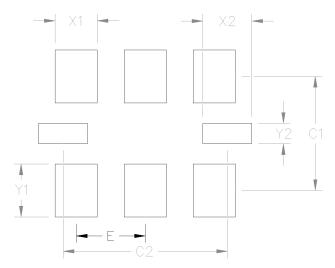


Figure 6.1. Si567 (5x7 mm) PCB Land Pattern

Table 6.1.	PCB Land	Pattern	Dimensions	(mm)
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Dimension	(mm)	Dimension	(mm)
C1	4.20	Y1	1.95
C2	6.05	X2	1.80
E	2.54	Y2	0.75
X1	1.55		

Notes:

General

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
- 3. This Land Pattern Design is based on the IPC-7351 guidelines.
- 4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.

Stencil Design

- 1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 2. The stencil thickness should be 0.125 mm (5 mils).
- 3. The ratio of stencil aperture to land pad size should be 1:1.

Card Assembly

- 1. A No-Clean, Type-3 solder paste is recommended.
- 2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

6.2 PCB Land Pattern (3.2x5 mm)

The figure below illustrates the 3.2x5.0 mm PCB land pattern for the Si567. The table below lists the values for the dimensions shown in the illustration.

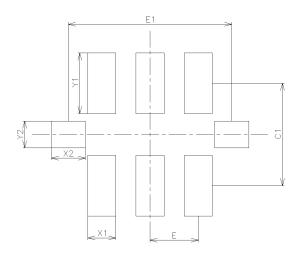




Table 6.2. PCB Land Pattern Dimensions (mm)

Dimension	(mm)	Dimension	(mm)
C1	2.70	X2	0.90
E	1.27	¥1	1.60
E1	4.30	Y2	0.70
X1	0.74		

Notes:

General

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
- 3. This Land Pattern Design is based on the IPC-7351 guidelines.
- 4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.

Stencil Design

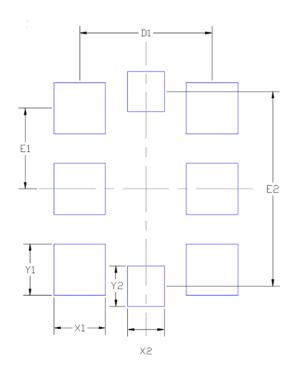
- 1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 2. The stencil thickness should be 0.125 mm (5 mils).
- 3. The ratio of stencil aperture to land pad size should be 1:1.

Card Assembly

- 1. A No-Clean, Type-3 solder paste is recommended.
- 2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

6.3 PCB Land Pattern (2.5x3.2 mm)

The figure below illustrates the 2.5x3.2 mm PCB land pattern for the Si567. The table below lists the values for the dimensions shown in the illustration.



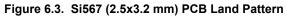


Table 6.3.	PCB Land	Pattern	Dimensions	(mm)
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Dimension	Description	Value (mm)
X1	Width - leads on long sides	0.7
Y1	Height - leads on long sides	0.7
X2	Width - single leads on short sides	0.5
Y2	Height - single leads on short sides	0.55
D1	Pitch in X directions of XL, Y1 leads	1.80
E1	Lead pitch X1, Y1 leads	1.10
E2	Lead pitch X2,Y2 leads	2.65

Si567 Data Sheet PCB Land Pattern

Dimension

Description

Notes:

General

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
- 3. This Land Pattern Design is based on the IPC-7351 guidelines.
- 4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.

Stencil Design

- 1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 2. The stencil thickness should be 0.125 mm (5 mils).
- 3. The ratio of stencil aperture to land pad size should be 0.8:1 for the pads.

Card Assembly

- 1. A No-Clean, Type-3 solder paste is recommended.
- 2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

7. Top Marking (5x7 and 3.2x5 Packages)

The figure below illustrates the mark specification for the Si567 5x7 and 3.2x5 package sizes. The table below lists the line information.

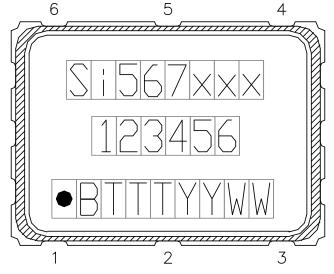


Figure 7.1. Mark Specification

Line	Position	Description
1	1–8	"Si567", xxx = Ordering Option 1, Option 2, Option 3 (e.g. Si567AAA)
2	1–6	Frequency Code (6-digit custom code as described in the Ordering Guide)
3	Trace Code	
	Position 1	Pin 1 orientation mark (dot)
	Position 2	Product Revision (B)
	Position 3–5	Tiny Trace Code (3 alphanumeric characters per assembly release instructions)
	Position 6–7	Year (last two digits of the year), to be assigned by assembly site (ex: 2017 = 17)
	Position 8–9	Calendar Work Week number (1–53), to be assigned by assembly site

8. Top Marking (2.5x3.2 Package)

The figure below illustrates the mark specification for the Si567 2.5x3.2 package sizes. The table below lists the line information.

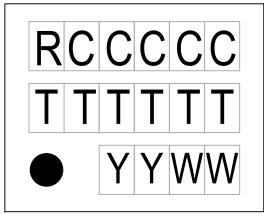


Figure 8.1. Mark Specification

Table 8.1. Si567 Top Mark Description

Line	Position	Description
1	1–6	R = Si567, CCCCC = Custom Mark Code
2	Trace Code	
	1–6	Six-digit trace code per assembly release instructions
3	Position 1	Pin 1 orientation mark (dot)
	Position 2–3	Year (last two digits of the year), to be assigned by assembly site (exp: 2017 = 17)
	Position 4–5	Calendar Work Week number (1–53), to be assigned by assembly site

9. Revision History

Revision 1.2

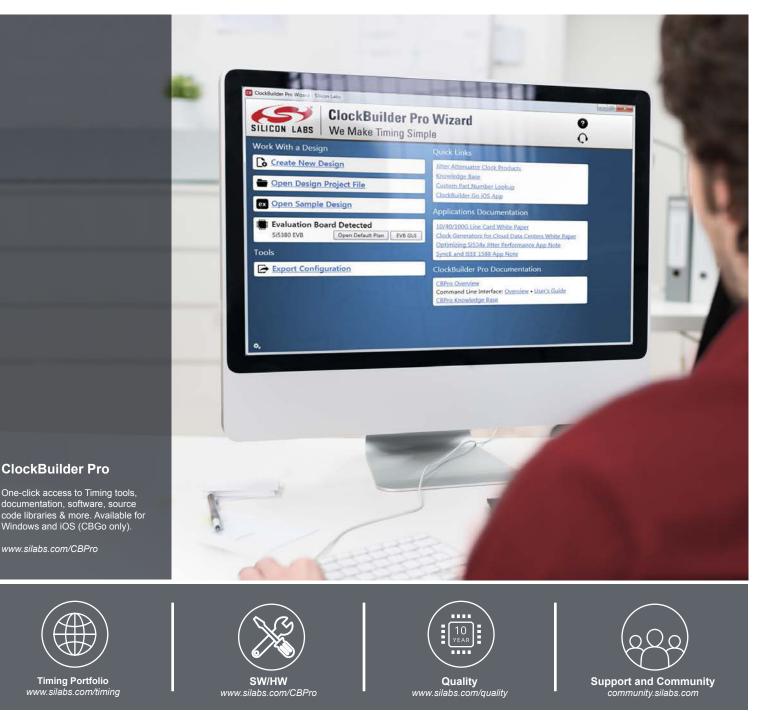
September, 2020

- Added 2.5 x 3.2 mm package option.
- Updated Table 2.2, Powerup VDD Ramp Rate and LVDS Swing.

Revision 1.0

June, 2018

Initial draft



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